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Sheet 1 of 2

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Application Number	10/811,230
Filing Date	March 26, 2004
First Named Inventor	Ganguli, et al.
Group Art Unit	1762
Examiner Name	Unknown
Attorney Docket Number	AMAT/5975.P2/CPI/L/B/PJS
Submission Date	September 20, 2004

Examiner Initials*	Cite No.1	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages or Relevant
		Number-Kind Code ^{2 (# known)}	MM-DD-YYYY	Applicant of Cited Document	Figures Appear
KMS	A1	US-6713373	03/30/2004	Omstead	
	A2	US-6617634	09/09/2003	Marsh, et al.	
	A3	US-6610568	08/26/2003	Marsh, et al.	
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Examiner /Kelly Stouffer/

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Substitute	for form 1449A/PTO			Application Number	10/811,230
				Filing Date	March 26, 2004
INFO	RMATION DISC	CLOS	SURE	First Named Inventor	Ganguli, et al.
STAT	NFORMATION DISCLOSURI STATEMENT BY APPLICAN	CAŃT	Group Art Unit	1762	
				Examiner Name	Unknown
	(Use as many sheets as necessary)			Attorney Docket Number	AMAT/5975.P2/CPI/L/B/PJS
Sheet	2	· of	2	Submission Date	September 20, 2004

	U.S. PATENT DOCUMENTS								
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages or Relevant				
Initials* No.1 Number-Kind Code ^{2 ()}		Number-Kind Code ^{2 (8 known)}	, MM-DD-YYYY	Applicant of Cited Document	Figures Appear				
KMS	A29	US-20020000587	01/03/2002	Kim, et al.					
KMS	A30	US-20010054730	12/27/2001	Kim, et al.					
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Examiner Cite No.1	Cite	Foreign Patent Document	Publication Date	Name of Patentee or	Pages, Columns, Lines,	T ⁶
	No.	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Where Relevant Passages or Relevant Figures Appear	
KMS	B1	WO 01/88972	11/22/2001		·	
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KMS	B3	JP 2001-111000	04/20/2001			

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KMS	C1	Aaltonen, et al., "Atomic Layer Deposition of Ruthenlum from RuCp₂ and Oxygen: Film Growth and Reaction Mechanism Studies," Electrochemical Society Proceedings Volume 2003-08 pp. 946-953.					
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	C9 .	Lim, et al.," Atomic layer deposition of transition metals," Nature Materials, Vol. 2 November (2003) pp. 749-754.					
V	C10	Shibutami, et al., "A Novel Ruthenium Precursor for MOCVD without Seed Ruthenium Layer," TOSOH Research & Technology Review, Vol. 47 (2003) pp. 61-64.					

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ction Act of 1995, n Information unless it displays a valid OMB control number. 10/811,230 Substitute for form 1449A/PTO Application Number Filing Date March 26, 2004 SUPPLEMENTAL INFORMATION First Named Inventor Ganguli, et al. SPISCLOSURE STATEMENT BY 1762 Group Art Unit **APPLICANT Examiner Name** Unknown AMAT/5975.P2/CPI/L/B/PJS (Use as many sheets as necessary) Attorney Docket Number Sheet **Submission Date** May 23, 2005

			ι	J.S.	PATENT	DO	CUMENTS				
Examiner	Cite	Document	Number	Publication Date MM-DD-YYYY		Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Relevant Passages or Re Figures Appear			
Initials*	No.1	Number-Kind (ant
KMS	A1	US-6887795		05/03/2005		SO	NINEN, ET AL.				
	A2	US-6800937		10/05	5/2004	MA	RSH, ET AL.				
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	A9	US-6576778		06/10	6/10/2003 4/01/2003		UHLENBROCK, ET AL. MARSH, ET AL.				
	A10	US-6541067		04/01							
	A11	US-6517616		02/11	1/2003	MARSH, ET AL. ZHANG, ET AL.				•	
	A12	US-6338991		01/15	5/2002						
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	A15	US-20040105934	,	06/03	3/2004						
	A16	US-20040038529		02/26	5/2004	SO	NINEN, ET AL.				
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KMS	B1	WO 03/056612			07/10/2003	GENITECH CO., LTD.		<u> </u>			
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Examiner Initials*	Cite N		oumal, serial, symp				de of the article (when appropria ate, page(s), volume-Issue numb			T²	
KMS	C1		International Search Report dated March 11, 2005 regarding International Application No. PCT/US2004/024805 (AMAT/5975PC02PCT)								
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1762 **Group Art Unit Examiner Name** Unknown **Attorney Docket Number** APPM/005975.P2/CPI/L/B/PJS **Submission Date** October 2005

			U.S	S. PATENT	DC	CUMENTS	_		
Examiner Initiats*	Cite No.1	Document Number		iblication Date		Name of Patentee or	Pages, Columns, Lines, When Relevant Passages or Releva		
		Number-Kind Code ^{2 (J known)}	I N	MIN-DD-1111		Applicant of Cited Document	Figures Appear		
KMS	A1	US 6790773	09/	/14/2004	Dre	ewery, et al.			
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KMS	B1	WO 2005/020317		03/03/2005		Chang, et al.	Molevant Figures Appea	'	
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09/21/2006 /Kelly Stouffer/ Examiner **Date Considered**

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